

## STD60NF3LL

N-channel 30V - 0.0075Ω - 60A - DPAK STripFET™ II Power MOSFET

#### **General features**

| Туре       | V <sub>DSS</sub> | V <sub>DSS</sub> R <sub>DS(on)</sub> |     |
|------------|------------------|--------------------------------------|-----|
| STD60NF3LL | 60V              | <0.0095Ω                             | 60A |

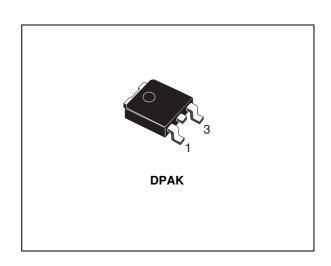
- $\blacksquare$  Optimal R<sub>DS(ON)</sub> x Q<sub>g</sub> trade-off @ 4.5V
- Conduction losses reduced
- Switching losses reduced

### **Description**

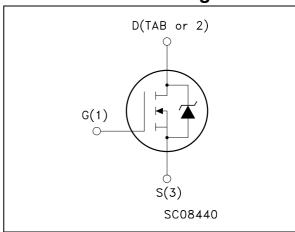
This application specific Power MOSFET is the third genaration of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows the best trade-off between on-resistance ang gate charge. When used as high and low side in buck regulators, it gives the best performance in terms of both conduction and switching losses. This is extremely important for motherboards where fast switching and high efficiency are of paramount importance.

### **Applications**

■ Switching application



#### Internal schematic diagram



#### **Order codes**

| Part number  | Marking  | Package | Packaging   |  |
|--------------|----------|---------|-------------|--|
| STD60NF3LLT4 | D60NF3LL | DPAK    | Tape & reel |  |

Contents STD60NF3LL

# **Contents**

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STD60NF3LL Electrical ratings

# 1 Electrical ratings

Table 1. Absolute maximum ratings

| Symbol                         | Parameter  | Value        | Unit |
|--------------------------------|--|--------------|------|
| V <sub>DS</sub>                | Drain-source voltage (V <sub>GS</sub> = 0)           | 30           | V    |
| V <sub>DGR</sub>               | Drain-gate voltage (R <sub>GS</sub> = 20 kΩ)         | 30           | V    |
| V <sub>GS</sub>                | Gate- source voltage                                 | ± 16         | V    |
| I <sub>D</sub>                 | Drain current (continuous) at T <sub>C</sub> = 25°C  | 60           | Α    |
| I <sub>D</sub>                 | Drain current (continuous) at T <sub>C</sub> = 100°C | 43           | Α    |
| I <sub>DM</sub> <sup>(1)</sup> | Drain current (pulsed)                               | 240          | Α    |
| P <sub>tot</sub>               | Total dissipation at T <sub>C</sub> = 25°C           | 100 W        |      |
|                                | Derating Factor                                      | 0.67 W       |      |
| E <sub>AS</sub> <sup>(2)</sup> | Single pulse avalanche energy                        | 700          | mJ   |
| T <sub>stg</sub>               | Storage temperature                                  | 55 to 175 °C |      |
| T <sub>j</sub>                 | Max. operating junction temperature                  | 55 to 175 °C |      |

<sup>1.</sup> Pulse width limited by safe operating area.

Table 2. Thermal data

| Rthj-case   | Thermal resistance junction-case max       | 1.5 | °C/W |
|---|--|-----|------|
| Rthj-amb  | Thermal resistance junction-to ambient max | 100 | °C/W |
| T <sub>J</sub> Maximum lead temperature for soldering purpose |  | 300 | °C   |

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<sup>2.</sup> Starting Tj=25°C,  $I_D$ =30A,  $V_{DD}$ =27.5V

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# 2 Electrical characteristics

( $T_{CASE}$ =25°C unless otherwise specified)

Table 3. On/off states

| Symbol               | Parameter  | Test conditions  | Min. | Тур.             | Max.             | Unit                     |
|----------------------|--|--|------|------------------|------------------|--------------------------|
| V <sub>(BR)DSS</sub> | Drain-source<br>breakdown voltage                        | $I_D = 250 \mu A, V_{GS} = 0$                                      | 30   |                  |                  | V                        |
| I <sub>DSS</sub>     | Zero gate voltage<br>drain current (V <sub>GS</sub> = 0) | $V_{DS}$ = Max rating<br>$V_{DS}$ = Max rating,<br>$T_{C}$ = 125°C |      |                  | 1<br>10          | μ <b>Α</b><br>μ <b>Α</b> |
| I <sub>GSS</sub>     | Gate-body leakage current (V <sub>DS</sub> = 0)          | V <sub>GS</sub> = ± 16V  |      |                  | ±100             | nA                       |
| V <sub>GS(th)</sub>  | Gate threshold voltage                                   | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$                               | 1    |                  |                  | ٧                        |
| R <sub>DS(on)</sub>  | Static drain-source on resistance                        | $V_{GS} = 10V, I_D = 30A$<br>$V_{GS} = 4.5V, I_D = 30A$            |      | 0.0075<br>0.0085 | 0.0095<br>0.0105 | Ω<br>Ω                   |

Table 4. Dynamic

| Symbol   | Parameter   | Test conditions  | Min. | Тур.                      | Max. | Unit           |
|--|---|--|------|---------------------------|------|----------------|
| 9 <sub>fs</sub> (1)  | Forward transconductance  | V <sub>DS</sub> = 15V, I <sub>D</sub> = 30A  |      | 30                        |      | S              |
| C <sub>iss</sub><br>C <sub>oss</sub><br>C <sub>rss</sub>   | Input capacitance Output capacitance Reverse transfer capacitance   | $V_{DS} = 25V, f = 1MHz,$<br>$V_{GS} = 0$  |      | 2210<br>635<br>138        |      | pF<br>pF<br>pF |
| $\begin{array}{c} t_{\text{d(on)}} \\ t_{\text{r}} \\ t_{\text{d(off)}} \\ t_{\text{f}} \end{array}$ | Turn-on delay time<br>Rise time<br>Turn-off delay time<br>Fall time | $V_{DD}$ = 15V, $I_D$ = 30A<br>$R_G$ = 4.7 $\Omega$ $V_{GS}$ = 4.5V<br>(see <i>Figure 12</i> )   |      | 22<br>130<br>36.5<br>36.5 |      | ns<br>ns<br>ns |
| Q <sub>g</sub><br>Q <sub>gs</sub><br>Q <sub>gd</sub>   | Total gate charge<br>Gate-source charge<br>Gate-drain charge        | $V_{DD}$ = 24V, $I_D$ = 60A,<br>$V_{GS}$ = 4.5V, $R_G$ = 4.7 $\Omega$<br>(see <i>Figure 13</i> ) |      | 30<br>9<br>12.5           | 40   | nC<br>nC<br>nC |

<sup>1.</sup> Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %.

Table 5. Source drain diode

| Symbol   | Parameter  | Test conditions  | Min. | Тур.             | Max.      | Unit          |
|--|--|--|------|------------------|-----------|---------------|
| I <sub>SD</sub>  | Source-drain current<br>Source-drain current<br>(pulsed)                     |  |      |                  | 60<br>240 | A<br>A        |
| V <sub>SD</sub> <sup>(2)</sup>                         | Forward on voltage   | I <sub>SD</sub> = 60A, V <sub>GS</sub> = 0   |      |                  | 1.2       | ٧             |
| t <sub>rr</sub><br>Q <sub>rr</sub><br>I <sub>RRM</sub> | Reverse recovery time<br>Reverse recovery charge<br>Reverse recovery current | $I_{SD}$ = 60A, di/dt = 100A/µs,<br>$V_{DD}$ = 15V, $T_j$ = 150°C<br>(see <i>Figure 14</i> ) |      | 65<br>105<br>3.4 |           | ns<br>nC<br>A |

<sup>1.</sup> Pulse width limited by safe operating area.

<sup>2.</sup> Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5 %

Electrical characteristics STD60NF3LL

## 2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

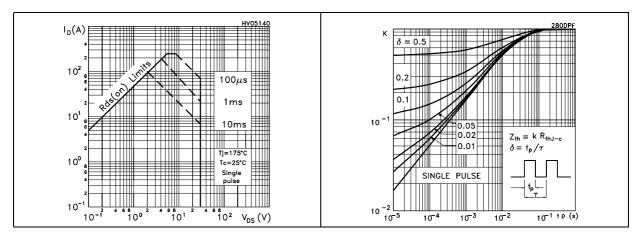


Figure 3. Output characterisics

Figure 4. Transfer characteristics

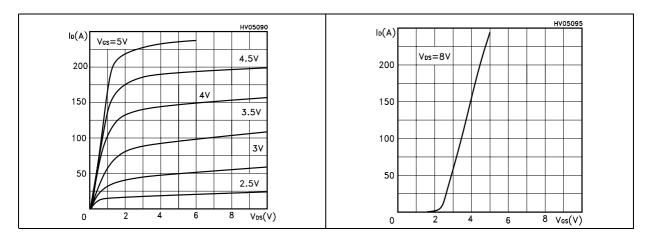
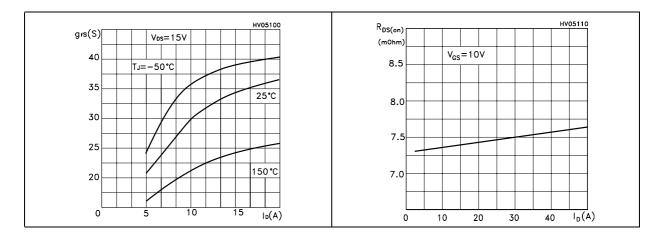


Figure 5. Transconductance

Figure 6. Static drain-source on resistance



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Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

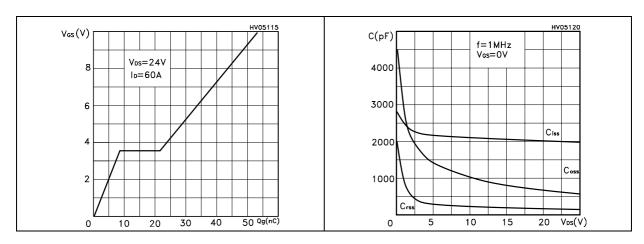


Figure 9. Normalized gate threshold voltage Figure 10. Normalized on resistance vs vs temperature temperature

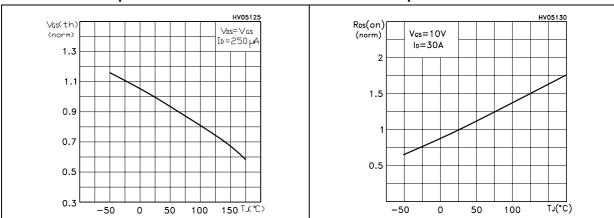
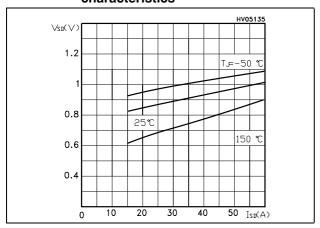


Figure 11. Source-drain diode forward characteristics



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Test circuit STD60NF3LL

## 3 Test circuit

Figure 12. Switching times test circuit for resistive load

Figure 13. Gate charge test circuit

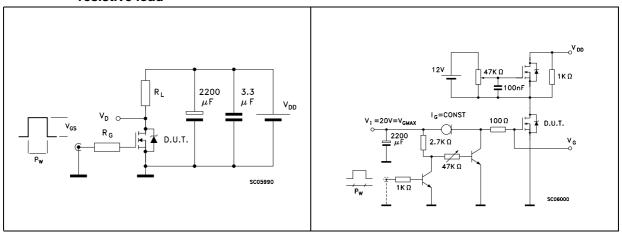


Figure 14. Test circuit for inductive load switching and diode recovery times

Figure 15. Unclamped Inductive load test circuit

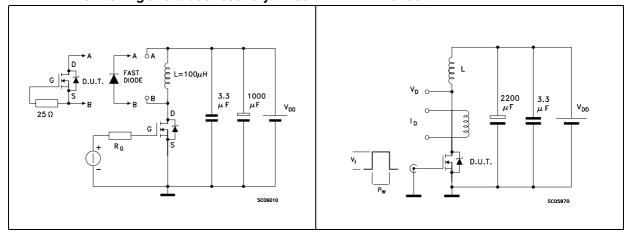
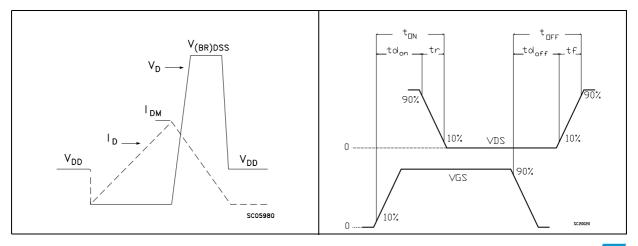


Figure 16. Unclamped inductive waveform

Figure 17. Switching time waveform



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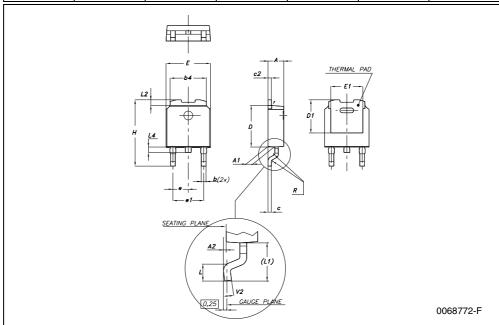
# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

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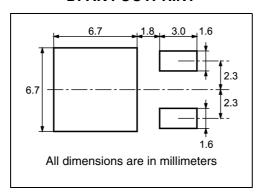
#### **DPAK MECHANICAL DATA**

| DIM  |      | mm.  |      |       |       |       |
|------|------|------|------|-------|-------|-------|
| DIM. | MIN. | TYP  | MAX. | MIN.  | TYP.  | MAX.  |
| Α    | 2.2  |      | 2.4  | 0.086 |       | 0.094 |
| A1   | 0.9  |      | 1.1  | 0.035 |       | 0.043 |
| A2   | 0.03 |      | 0.23 | 0.001 |       | 0.009 |
| В    | 0.64 |      | 0.9  | 0.025 |       | 0.035 |
| b4   | 5.2  |      | 5.4  | 0.204 |       | 0.212 |
| С    | 0.45 |      | 0.6  | 0.017 |       | 0.023 |
| C2   | 0.48 |      | 0.6  | 0.019 |       | 0.023 |
| D    | 6    |      | 6.2  | 0.236 |       | 0.244 |
| D1   |      | 5.1  |      |       | 0.200 |       |
| Е    | 6.4  |      | 6.6  | 0.252 |       | 0.260 |
| E1   |      | 4.7  |      |       | 0.185 |       |
| е    |      | 2.28 |      |       | 0.090 |       |
| e1   | 4.4  |      | 4.6  | 0.173 |       | 0.181 |
| Н    | 9.35 |      | 10.1 | 0.368 |       | 0.397 |
| L    | 1    |      |      | 0.039 |       |       |
| (L1) |      | 2.8  |      |       | 0.110 |       |
| L2   |      | 0.8  |      |       | 0.031 |       |
| L4   | 0.6  |      | 1    | 0.023 |       | 0.039 |
| R    |      | 0.2  |      |       | 0.008 |       |
| V2   | 0°   |      | 8°   | 0°    |       | 8°    |

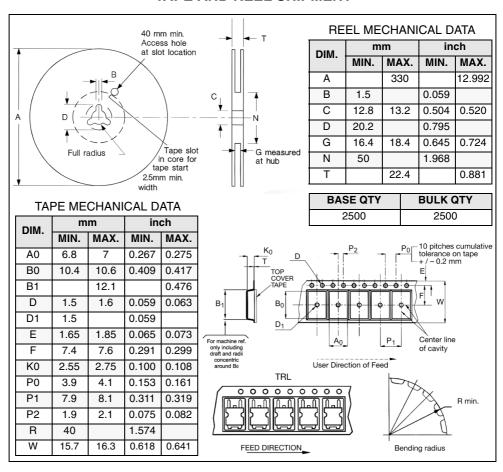


## 5 Packing mechanical data

#### **DPAK FOOTPRINT**



#### TAPE AND REEL SHIPMENT



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Revision history STD60NF3LL

# 6 Revision history

Table 6. Revision history

| Date        | Revision | Changes                         |
|-------------|----------|---------------------------------|
| 09-Sep-2004 | 4        | Preliminary version             |
| 19-Jul-2006 | 5        | New template, no content change |

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